the Caddo Nation of Oklahoma that this notice has been published.

Dated: November 14, 2007

#### Sherry Hutt,

Manager, National NAGPRA Program. [FR Doc. E7–24619 Filed 12–18–07; 8:45 am] BILLING CODE 4312–50–8

## INTERNATIONAL TRADE COMMISSION

[Inv. No. 337-TA-596]

In the Matter of Certain GPS Chips, Associated Software and Systems, and Products Containing Same; Notice of Commission Determination not to Review ALJ Order; No. 22 Granting Complainant's Motion to Amend the Complaint and Notice of Investigation

**AGENCY:** U.S. International Trade Commission.

ACTION: Notice.

**SUMMARY:** Notice is hereby given that the U.S. International Trade Commission has determined not to review an initial determination ("ID") (Order No. 22) of the presiding administrative law judge ("ALJ") granting complainant's motion to amend the complaint and notice of investigation.

FOR FURTHER INFORMATION: Michael Liberman, Esq., Office of the General Counsel, U.S. International Trade Commission, 500 E Street, SW., Washington, DC 20436, telephone 202-205-3152. Copies of the ID and all other nonconfidential documents filed in connection with this investigation are or will be available for inspection during official business hours (8:45 a.m. to 5:15 p.m.) in the Office of the Secretary, U.S. International Trade Commission, 500 E Street, SW., Washington, DC 20436, telephone 202-205-2000. Hearing-impaired persons are advised that information on this matter can be obtained by contacting the Commission's TDD terminal on 202-205-1810. General information concerning the Commission may also be obtained by accessing its Internet server (http://www.usitc.gov). The public record for this investigation may be viewed on the Commission's electronic docket (EDIS) at http://edis.usitc.gov.

SUPPLEMENTARY INFORMATION: On March 13, 2007, the Commission instituted an investigation under section 337 of the Tariff Act of 1930, 19 U.S.C. 1337, based on a complaint filed by SiRF Technology, Inc. of San Jose, California ("SiRF"), alleging a violation of section 337 in the importation, sale for

importation, and sale within the United States after importation of certain GPS chips, associated software and systems, and products containing same by reason of infringement of certain claims of U.S. Patent Nos. 6,304,216; 7,043,363; 7,091,904 ("the '904 patent"); and 7,132,980. 72 FR 11378 (Mar. 13, 2007). The complainant named Global Locate, Inc. of San Jose, California as respondent. The complaint and notice of investigation were later amended to include one additional claim of the '904 patent. Subsequently, the investigation was terminated with respect to the '904 patent and certain claims of the other patents.

On November 7, 2007, complainant SiRF moved for leave to amend the complaint and notice of investigation to add Broadcom, Inc. as a respondent to the investigation.

On November 16, 2007, the ALJ issued Order No. 22 granting complainant's motion. No party petitioned for review of Order No. 22. The Commission has determined not to review the ID.

The authority for the Commission's determination is contained in section 337 of the Tariff Act of 1930, as amended (19 U.S.C. 1337), and in section 210.42(h) of the Commission's Rules of Practice and Procedure (19 CFR 210.42(h)).

Issued: December 13, 2007.

By order of the Commission.

### Marilyn R. Abbott,

 $Secretary\ to\ the\ Commission.$ 

[FR Doc. E7–24585 Filed 12–18–07; 8:45 am]  $\tt BILLING\ CODE\ 7020-02-P$ 

## INTERNATIONAL TRADE COMMISSION

[Investigation No. 731-TA-909 (Review)]

# Low Enriched Uranium From France Determination

On the basis of the record <sup>1</sup> developed in the subject five-year review, the United States International Trade Commission (Commission) determines, pursuant to section 751(c) of the Tariff Act of 1930 (19 U.S.C. 1675(c)), that revocation of the antidumping duty order on low enriched uranium from France would be likely to lead to continuation or recurrence of material injury to an industry in the United States within a reasonably foreseeable time.<sup>2</sup>

### **Background**

The Commission instituted this review on January 3, 2007 (72 FR 144) and determined on April 9, 2007 that it would conduct a full review (72 FR 27151, May 14, 2007). Notice of the scheduling of the Commission's review and of a public hearing to be held in connection therewith was given by posting copies of the notice in the Office of the Secretary, U.S. International Trade Commission, Washington, DC, and by publishing the notice in the Federal Register on May 31, 2007 (72 FR 30393). The hearing was held in Washington, DC, on October 11, 2007, and all persons who requested the opportunity were permitted to appear in person or by counsel.

The Commission transmitted its determination in this review investigation to the Secretary of Commerce on December 13, 2007. The views of the Commission are contained in USITC Publication 3967 (December 2007), entitled Low Enriched Uranium from France: Investigation No. 731–TA–909 (Review).

Issued: December 13, 2007.

By order of the Commission.

### Marilyn R. Abbott,

Secretary to the Commission.
[FR Doc. E7–24587 Filed 12–18–07; 8:45 am]
BILLING CODE 7020–02–P

## INTERNATIONAL TRADE COMMISSION

[Inv. No. 337-TA-621]

In the Matter of Certain Probe Card Assemblies, Components Thereof and Certain Tested Dram and Nand Flash Memory Devices and Products Containing Same; Notice of Investigation

**AGENCY:** U.S. International Trade Commission.

**ACTION:** Institution of investigation pursuant to 19 U.S.C. 1337.

**SUMMARY:** Notice is hereby given that a complaint was filed with the U.S. International Trade Commission on November 13, 2007, under section 337 of the Tariff Act of 1930, as amended, 19 U.S.C. 1337, on behalf of FormFactor, Inc. of Livermore, California. An amended complaint was filed on December 7, 2007. The complaint, as amended, alleges violations of section 337 in the importation into the United States, the sale for importation, and the sale within the United States after importation of certain probe card assemblies, components thereof and certain tested DRAM and NAND flash

<sup>&</sup>lt;sup>1</sup>The record is defined in section 207.2(f) of the Commission's Rules of Practice and Procedure (19 CFR 207.2(f)).

<sup>&</sup>lt;sup>2</sup> Commissioner Deana Tanner Okun did not participate in this review.